

S P T P
FORM PTO-1449 (MODIFIED)

ATTORNEY DOCKET NO.

SERIAL NO.

LIST OF PATENTS AND MAR 21 2003
PUBLICATIONS
FOR APPLICANTS INFORMATION
DISCLOSURE STATEMENT

SP03-090

10,626,310

APPLICANT: Roger A. Allaire, et al.

FILING DATE July 24, 2003

GROUP: 3723

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
DVN	AA	2,332,329/	10/19/1943	US			
DVN	AB	2,969,624/	01/31/1961	US			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
DVN	AL	JP 58217264/	12/17/1983	Japan			
DVN	AM	DT 1652060/	10/28/1967	Germany			
	AN						
	AO						
	AP						
	AQ						

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

AR	
AS	
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EXAMINER:

Douglas van Hooydonk

DATE CONSIDERED:

3-28-2005

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 (MODIFIED)		ATTORNEY DOCKET NO.	SERIAL NO.
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT		ADP-170 (SP03-090)	10/626,310
		APPLICANT Roger A. Allaire et al.	
		FILING DATE	GROUP: 3723 TBA

REFERENCE DESIGNATION		U.S. PATENT DOCUMENTS					
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
DVN	AA	5,975,992	11-02-99	Bruce H. Raeder et al.	451	44	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AJ						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
DVN	AL	1 060 833 A1	12-20-00	Europe			X
	AM						
	AN						
	AO						
	AP						
	AQ						

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)							
	AR						
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EXAMINER: *Shing van Nguyen* DATE CONSIDERED: 1-21-2005

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